Information Disclosure Statement USSN 09/829,781 April 8, 2003

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Form PTO-1449 (Modified) RADENTS	ATTY DOCKET NO. B-3916 617818-6	U.S. SERIAL NO. 09/829,781		
LIST OF PATENTS AND PUBLICATIONS	APPLICANT(S) Tsung-Yuan Hsu			
STATEMENT	PILING DATE April 10, 2001	GROUP 2881		

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE or 102(e) DATE IF APPROPRIATE
7	5,917,179	6/1999	Yao	250	227.11	
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	Pfeiffer, T., et al., "40 GHz Pulse Generation Using a Widely Tunable All-Polarisation Preserving Erbium Fibre Ring Laser," <i>Electronics Letters</i> , Vol. 29, No. 21, pp 1849-1850 (October 14, 1993).
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m	12/30/6]
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